

<Intelligent Power Modules>

PM25CG1B120

FLAT-BASE TYPE INSULATED PACKAGE



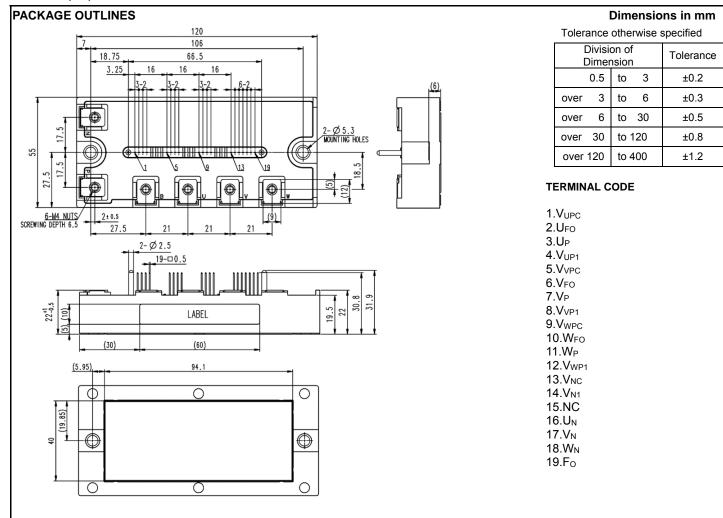
FEATURE

- a) Adopting Full-Gate CSTBT™ chip.
- b) The over-temperature protection which detects the chip surface temperature of CSTBT™ is adopted.
- c) Error output signal is available from each protection upper and lower arm of IPM.
- d) Outputting an error signal corresponding to the abnormal state (error mode identification)

UL Recognized under UL1557, File No. E323585
This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

APPLICATION

General purpose inverter, servo drives and other motor controls

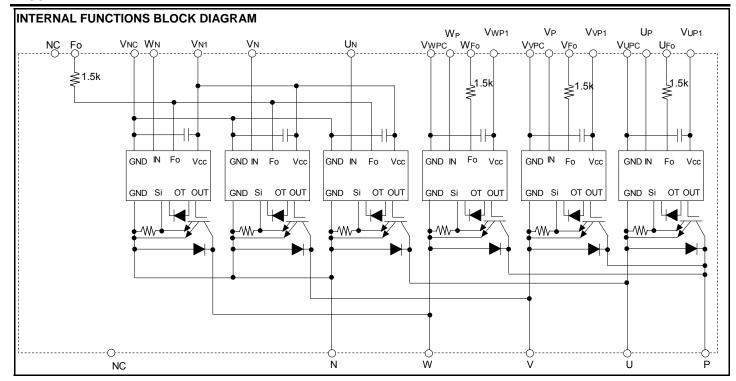


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Publication date: Nov, 2017

HIGH POWER SWITCHING USE

INSULATED TYPE



MAXIMUM RATINGS (Tvj = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15 V, V _{CIN} =15 V	1200	V
I _C	Collegator Comment	T _C =25 °C	25	
I _{CRM}	Collector Current	Pulse	50	Α
P _{tot}	Total Power Dissipation	T _C =25 °C	260	W
l _E	Emitter Current	T _C =25 °C	25	^
I _{ERM}	(Free-wheeling Diode Forward current)	Pulse	50	Α
Tvj	Junction Temperature		-20 ~ +150	°C

^{*:} Tc measurement point is just under the chip.

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
V_D	Supply Voltage	Applied between: V _{UP1} -V _{UPC} , V _{VP1} -V _{VPC} , V _{WP1} -V _{WPC} , V _{N1} -V _{NC}	20	V
V_{CIN}	Input Voltage	Applied between: U _P -V _{UPC} , V _P -V _{VPC} , W _P -V _{WPC} , U _N , V _N , W _N -V _{NC}	20	V
V_{FO}	Fault Output Supply Voltage	Applied between: U _{FO} -V _{UPC} , V _{FO} -V _{VPC} , W _{FO} -V _{WPC} , Fo-V _{NC}	20	V
I _{FO}	Fault Output Current	Sink current at U _{FO} , V _{FO} , W _{FO} , Fo terminals	20	mA

TOTAL SYSTEM

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	V _D =13.5 V~16.5 V, Inverter Part, Tvj=+125°C start	800	V
T _{stg}	Storage Temperature	-	-40 ~ +125	°C
Tc	Operating Case Temperature	-	-20 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

^{*:} Tc measurement point is just under the chip.

HIGH POWER SWITCHING USE

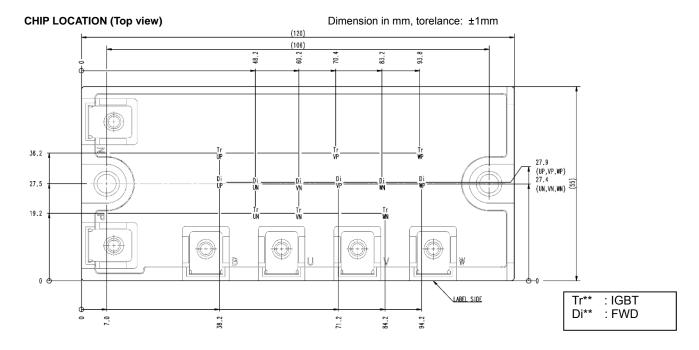
INSULATED TYPE

THERMAL RESISTANCE

Symbol	Parameter	Conditions	Limits			Unit
Syllibol	Falametei		Min.	Тур.	Max.	Offic
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT, per 1 element (Note1)	-	-	0.48	K/W
$R_{th(j-c)D}$		Junction to case, FWD, per 1 element (Note1)	-	-	0.78	r/vv
$R_{th(c-s)}$	Contact Thermal Resistance	Case to heat sink, per 1 module,	_	14.4	_	K/kW
		Thermal grease applied (Note.1, 2)				

Note1. If you use this value, $R_{\text{th(s-a)}}$ should be measured just under the chips.

Note2. Typical value is measured by using thermally conductive grease of λ =0.9W/(m·K), $D_{(C-S)}$ =50 μ m.



ELECTRICAL CHARACTERISTICS (Tvj= 25°C, unless otherwise noted)

INVERTER PART

Cumbal	Parameter	Conditions		Limits			Unit	
Symbol	Parameter	Conditions			Min.	Тур.	Max.	Unit
		V _D =15 V, I _C =25 A Tvj=25 °C	T:-25 %C	Terminal	-	-	1.7	
V	Collector-Emitter Saturation Voltage		1 Vj=25 C	Chip	-	1.3	-	V
V _{CEsat}		V =0.V Dulood (Fig. 1)	Tvj=125 °C	Terminal	-	-	1.95	V
		V _{CIN} =0 V, Pulsed, (Fig.1)	1 Vj=125 C	Chip	-	1.5	-	
	Emitter-Collector Voltage	V _D =15 V, I _E =25 A, Tvj=25 °C	Tvi=25 °C	Terminal	-	-	2.35	· v
V _{EC}			1 Vj=25 C	Chip	-	1.75	-	
		V _{CIN} = 15 V, pulsed, (Fig.2) Tvj=125 °C	Tvi=125 °C	Terminal	-	-	2.6	
			Chip	-	1.95	ı		
t _{on}		$V_D=15 \text{ V}, V_{CIN}=0 \text{ V} \longleftrightarrow 15 \text{ V},$ $V_{CC}=600 \text{ V}, I_C=25\text{A},$		0.3	0.7	1.2		
t _{rr}				-	0.13	0.4		
t _{c(on)}	Switching Time	Tvj=125 °C,	=125 °C,		-	0.2	0.4	μs
t _{off}		Inductive Load		-	1.0	2.8		
t _{c(off)}		(Fig.3, 4)		-	0.4	1.2		
	College of Consistent Court off Courses	$V_{CE}=V_{CES}$, $V_D=15$ V,		Tvj=25 °C	-	-	1	A
I _{CES}	Collector-Emitter Cut-off Current	$V_{CIN}=15 \text{ V} \text{ (Fig.5)}$		Tvj=125 °C	-	-	10	mA

HIGH POWER SWITCHING USE

INSULATED TYPE

ELECTRICAL CHARACTERISTICS (Tvj = 25°C, unless otherwise noted)

CONTROL PART

Cymbal	Parameter	Conditions	Conditions		Limits		
Symbol	Talameter Conditions			Min.	Тур.	Max.	Unit
		$V_D = 15 \text{ V}, V_{CIN} = 15 \text{ V}$	V _{P1} -V _{PC}	-	4	6	
	Circuit Current		V _{N1} -V _{NC}	-	12	18	^
ID	Circuit Current	V _D =15 V, V _{CIN} =0 V↔15 V, V _{CC} =800 V	V _{P1} -V _{PC}	-	10	12	mA
		I _C =0A, Tvj=125 °C, f _C ≤20kHz	V _{N1} -V _{NC}	-	30	36	
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between:		1.2	1.5	1.8	V
$V_{th(OFF)}$	Input OFF Threshold Voltage	U_P - V_{UPC} , V_P - V_{VPC} , W_P - V_{WPC} , U_N , V_N , W_N - V_N	/ _{NC}	1.7	2.0	2.3	V
SC	Short Circuit Trip Level	-20≤Tvj≤125 °C, V _D =15 V (Fig.3, 6)		50	-	-	Α
t _{d(SC)}	Short Circuit Current Delay Time	V _D =15 V, Tvj=125 °C (Fig.3, 6)		-	2.0	-	μs
ОТ	Over Terror and the Bustonian	Detection of IODT skin and	Trip level	150	-	-	°C
OT _(hys)	Over Temperature Protection	Detect temperature of IGBT chip surface	Hysteresis	-	20	-	
UV _t	Supply Circuit		Trip level	11.0	12.0	12.7	V
UV _r	Under-Voltage Protection	-	Reset level	-	12.5	-	V
I _{FO(H)}	Foult Output Current	V =15 V V =15 V (Note2)		-	-	0.01	A
I _{FO(L)}	Fault Output Current	V _D =15 V, V _{FO} =15 V (Note3)		-	10	15	mA
		V _D =15 V (Note3)	ОТ	-	8.0	-	
t_{FO}	Fault Output Pulse Width		UV	-	4.0	-	ms
			SC	-	2.0	-	

Note3. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

MECHANICAL RATINGS AND CHARACTERISTICS

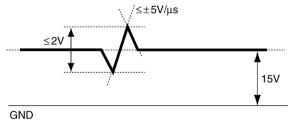
MILONANICAL NATINGO AND CHANACTERIOTICS							
Symbol	Parameter	Conditions	Limits			Unit	
		Conditions		Тур.	Max.	UIIIL	
Ms	Mounting Torque	Mounting part screw : M5	2.5	3.0	3.5	N•m	
Mt	Mounting Torque	Main terminal part screw : M4	1.5	1.7	2.0	111-111	
m	mass	-	-	260	-	g	

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V _{cc}	Supply Voltage	Applied across P-N terminals	≤ 800	V
V _D	Control Supply Voltage	Applied between: VUP1-VUPC, VVP1-VVPC, VWP1-VWPC, VN1-VNC (Note4)	15.0±1.5	٧
V _{CIN(ON)}	Input ON Voltage	Applied between :	≤ 0.8	V
V _{CIN(OFF)}	Input OFF Voltage	U_{P} - V_{UPC} , V_{P} - V_{VPC} , W_{P} - V_{WPC} , U_{N} , V_{N} , W_{N} - V_{NC}	≥ 9.0	V
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t _{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig.7)	≥ 2.5	μs

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Note4. With ripple satisfying the following conditions: dv/dt swing ≤ ±5 V/µs, Variation ≤ 2 V peak to peak



PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
 - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above VCES rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)

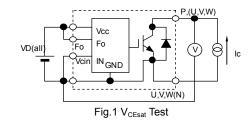
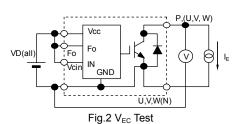


Fig.3 Switching time and SC test circuit



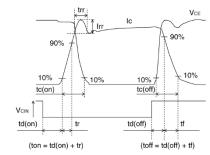


Fig.4 Switching time test waveform

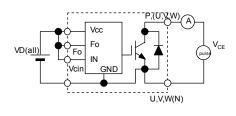


Fig.5 I_{CES} Test

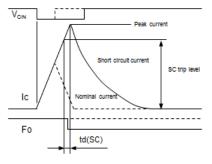
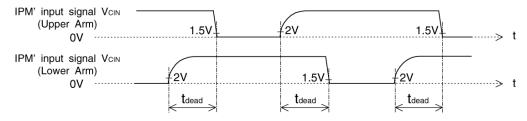


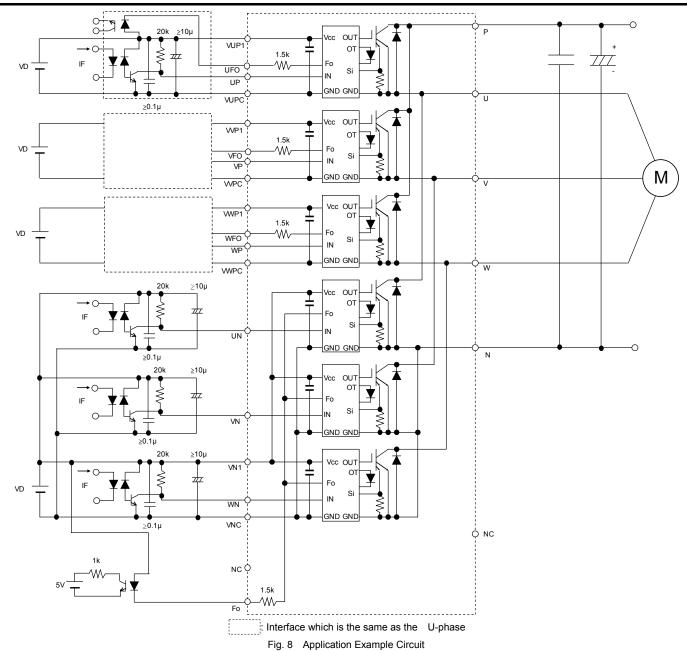
Fig.6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example

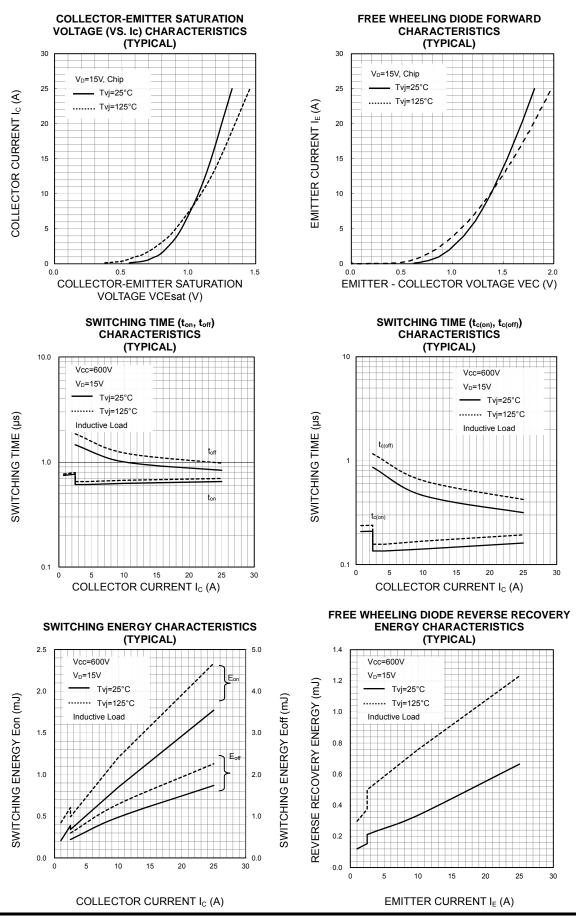
INSULATED TYPE



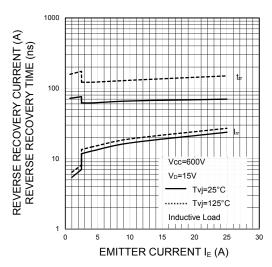
NOTES FOR STABLE AND SAFE OPERATION;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- · Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \le 0.8 \mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- $\bullet \ \ \text{Use 4 isolated control power supplies (V_D)}. \ Also, care should be taken to minimize the instantaneous voltage charge of the power supply.$
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

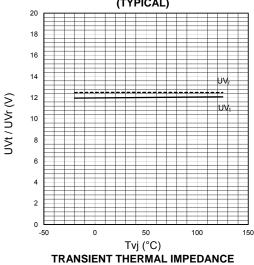
PERFORMANCE CURVES



FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

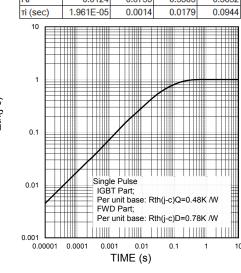


UV TRIP LEVEL VS. Tvj CHARACTERISTICS (TYPICAL)

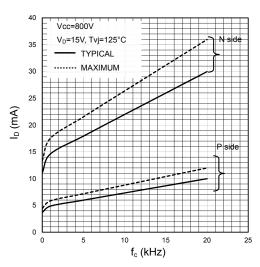


(TYPICAL) i 1 2 3 4 Ri 0.0124 0.0739 0.3505 0.5632

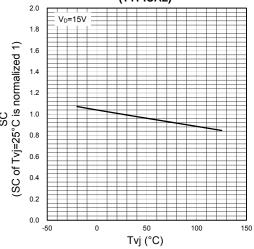
CHARACTERISTICS



I_D VS. f_C CHARACTERISTICS (TYPICAL, MAXIMUM)



SC TRIP LEVEL VS. Tvj CHARACTERISTICS (TYPICAL)



NORMARIZED TRANSIENT THERMAL IMPEDANCE

HIGH POWER SWITCHING USE INSULATED TYPE

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